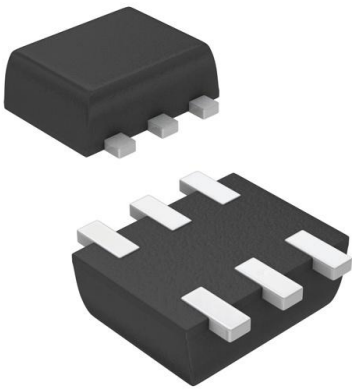


# FDY4001CZ Datasheet

[www.digi-electronics.com](http://www.digi-electronics.com)



<https://www.DiGi-Electronics.com>

DiGi Electronics Part Number	FDY4001CZ-DG
Manufacturer	<a href="#">onsemi</a>
Manufacturer Product Number	FDY4001CZ
Description	MOSFET N/P-CH 20V 0.2A SOT563F
Detailed Description	Mosfet Array 20V 200mA, 150mA 446mW Surface Mount SOT-563F



Tel: +00 852-30501935

RFQ Email: [Info@DiGi-Electronics.com](mailto:Info@DiGi-Electronics.com)

DiGi is a global authorized distributor of electronic components.

## Purchase and inquiry

Manufacturer Product Number:

FDY4001CZ

Series:

PowerTrench®

Technology:

MOSFET (Metal Oxide)

FET Feature:

Logic Level Gate

Current - Continuous Drain (Id) @ 25°C:

200mA, 150mA

Vgs(th) (Max) @ Id:

1.5V @ 250µA

Input Capacitance (Ciss) (Max) @ Vds:

60pF @ 10V

Operating Temperature:

-55°C ~ 150°C (Tj)

Package / Case:

SOT-563, SOT-666

Base Product Number:

FDY40

Manufacturer:

onsemi

Product Status:

Obsolete

Configuration:

N and P-Channel

Drain to Source Voltage (Vdss):

20V

Rds On (Max) @ Id, Vgs:

50hm @ 200mA, 4.5V

Gate Charge (Qg) (Max) @ Vgs:

1.1nC @ 4.5V

Power - Max:

446mW

Mounting Type:

Surface Mount

Supplier Device Package:

SOT-563F

## Environmental & Export classification

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

REACH Status:

REACH Unaffected

HTSUS:

8541.21.0095

**FAIRCHILD**  
SEMICONDUCTOR®

August 2006

## FDY4001CZ

# Complementary N & P-Channel PowerTrench® MOSFET

### Features

Q1: N-Channel

- Max  $r_{DS(on)}$  = 5Ω at  $V_{GS} = 4.5V$ ,  $I_D = 200mA$
- Max  $r_{DS(on)}$  = 7Ω at  $V_{GS} = 2.5V$ ,  $I_D = 175mA$
- Max  $r_{DS(on)}$  = 9Ω at  $V_{GS} = 1.8V$ ,  $I_D = 150mA$

Q2: P-Channel

- Max  $r_{DS(on)}$  = 8Ω at  $V_{GS} = -4.5V$ ,  $I_D = -150mA$
- Max  $r_{DS(on)}$  = 12Ω at  $V_{GS} = -2.5V$ ,  $I_D = -125mA$
- Max  $r_{DS(on)}$  = 15Ω at  $V_{GS} = -1.8V$ ,  $I_D = -100mA$
- ESD protection diode (note 3)
- RoHS Compliant

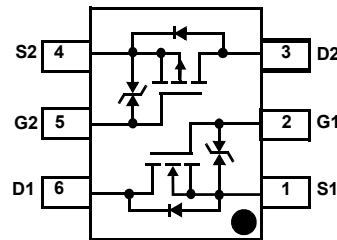
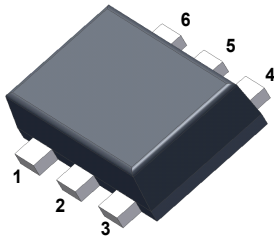


### General Description

This Complementary N & P-Channel MOSFET has been designed using Fairchild Semiconductor's advanced PowerTrench® process to optimize the  $r_{DS(on)}$  @  $V_{GS}=2.5V$  and specify the  $r_{DS(on)}$  @  $V_{GS} = 1.8V$ .

### Applications

- Level shifting
- Power Supply Converter Circuits
- Load/Power Switching Cell Phones, Pagers



### MOSFET Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

Symbol	Parameter	Q1	Q2	Units
$V_{DS}$	Drain to Source Voltage	20	-20	V
$V_{GS}$	Gate to Source Voltage	±12	±8	V
$I_D$	Drain Current -Continuous (Note 1a)	200	-150	mA
	-Pulsed	1000	-1000	
$P_D$	Power Dissipation (Steady State) (Note 1a)	625		mW
		446 (Note 1b)		
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150		$^\circ C$

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	200	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	280	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
F	FDY4001CZ	SC89-6	7"	8mm	3000units

**Electrical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
--------	-----------	-----------------	------	-----	-----	-----	-------

**Off Characteristics**

$B_{VDSS}$	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ $I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$	Q1 Q2	20 -20			V
$\frac{\Delta B_{VDSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , referenced to $25^\circ\text{C}$ $I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$	Q1 Q2		14 -15		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 16\text{V}, V_{GS} = 0\text{V}$ $V_{DS} = -16\text{V}, V_{GS} = 0\text{V}$	Q1 Q2			1 -3	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage	$V_{GS} = \pm 12\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = \pm 4.5\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = \pm 8\text{V}, V_{DS} = 0\text{V}$	Q1 Q1 Q2			$\pm 10$ $\pm 1$ $\pm 10$	$\mu\text{A}$

**On Characteristics** (note 2)

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ $V_{GS} = V_{DS}, I_D = -250\mu\text{A}$	Q1 Q2	0.6 -0.65	-1.0	1.5 -1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , referenced to $25^\circ\text{C}$ $I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$	Q1 Q2		2.8 -3		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Drain to Source On Resistance	$V_{GS} = 4.5\text{V}, I_D = 200\text{mA}$ $V_{GS} = 2.5\text{V}, I_D = 175\text{mA}$ $V_{GS} = 1.8\text{V}, I_D = 150\text{mA}$ $V_{GS} = 1.5\text{V}, I_D = 20\text{mA}$ $V_{GS} = 4.5\text{V}, I_D = 200\text{mA}, T_J = 125^\circ\text{C}$ $V_{GS} = -4.5\text{V}, I_D = -150\text{mA}$ $V_{GS} = -2.5\text{V}, I_D = -125\text{mA}$ $V_{GS} = -1.8\text{V}, I_D = -100\text{mA}$ $V_{GS} = -1.5\text{V}, I_D = -30\text{mA}$ $V_{GS} = -4.5\text{V}, I_D = -150\text{mA}, T_J = 125^\circ\text{C}$	Q1    Q2			5 7 9 10 7 8 12 15 20 12	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 5\text{V}, I_D = 200\text{mA}$ $V_{DS} = -5\text{V}, I_D = -150\text{mA}$	Q1 Q2		1.1 0.7		S

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	Q1 $V_{DS} = 10\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$	Q1 Q2		60 100		pF
$C_{oss}$	Output Capacitance	Q2	Q1 Q2		20 30		pF
$C_{riss}$	Reverse Transfer Capacitance	$V_{DS} = -10\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$	Q1 Q2		10 15		pF

**Switching Characteristics**

$t_{d(on)}$	Turn-On Delay Time	Q1 $V_{DD} = 10\text{V}, I_D = 1\text{A}$	Q1 Q2		6 6	12 12	ns
$t_r$	Rise Time	$V_{GS} = 4.5\text{V}, R_g = 6\Omega$	Q1 Q2		8 13	16 23	ns
$t_{d(off)}$	Turn-Off Delay Time	Q2 $V_{DD} = -10\text{V}, I_D = -0.5\text{A}$	Q1 Q2		8 8	16 16	ns
$t_f$	Fall Time	$V_{GS} = -4.5\text{V}, R_g = 6\Omega$	Q1 Q2		2.4 1	4.8 2	ns
$Q_g$	Total Gate Charge	Q1 $V_{DS} = 10\text{V}, I_D = 200\text{mA}, V_{GS} = 4.5\text{V}$	Q1 Q2		0.8 1.0	1.1 1.4	nC
$Q_{gs}$	Gate to Source Gate Charge	Q1 Q2	Q1 Q2		0.16 0.2		nC
$Q_{gd}$	Gate to Drain "Miller" Charge	Q1 Q2 $V_{DS} = -10\text{V}, I_D = -150\text{mA}, V_{GS} = -4.5\text{V}$	Q1 Q2		0.26 0.3		nC

**Electrical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
--------	-----------	-----------------	------	-----	-----	-----	-------

**Drain-Source Diode Characteristics**

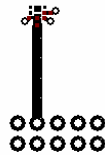
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = 150\text{mA}$ (Note 2)	Q1		0.7	1.2	V
		$V_{GS} = 0\text{V}, I_S = -150\text{mA}$ (Note 2)	Q2		-0.8	-1.2	
$t_{rr}$	Reverse Recovery Time	$I_F = 200\text{mA}, di/dt = 100\text{A}/\mu\text{s}$	Q1		12		ns
			Q2		11		
$Q_{rr}$	Reverse Recovery Charge	$I_F = -150\text{mA}, di/dt = 100\text{A}/\mu\text{s}$	Q1		3		nC
			Q2		2		

**Notes:**

1:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a)  $200^\circ\text{C}/\text{W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper



b)  $280^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper

Scale 1:1 on letter size paper

2: Pulse Test : Pulse Width < 300us, Duty Cycle < 2.0%

3: The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

### Typical Characteristics Q1 (N-Channel)

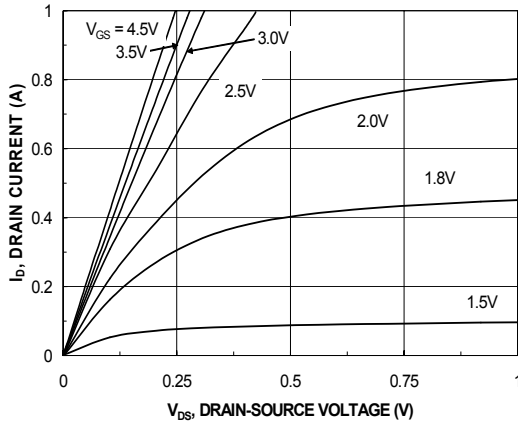


Figure 1. On-Region Characteristics.

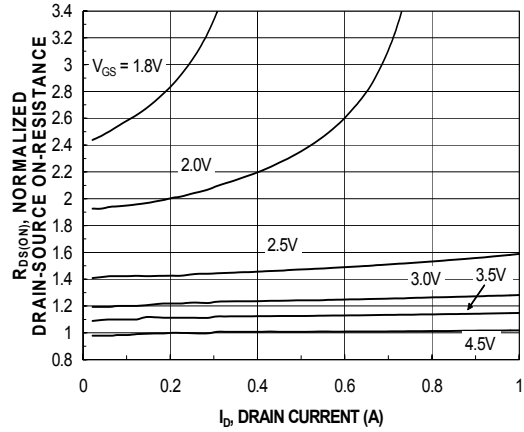


Figure 2. Normalized on-Resistance vs. Drain Current and Gate Voltage.

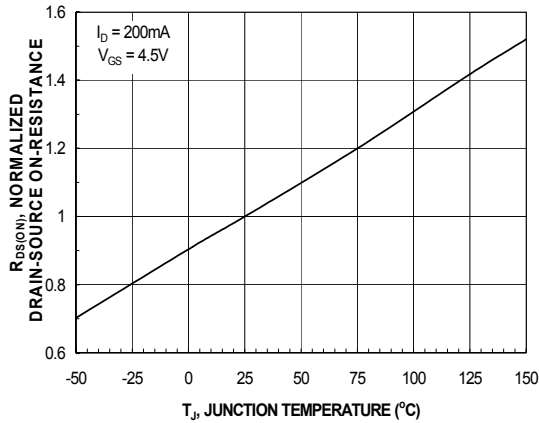


Figure 3. Normalized on-Resistance vs. Temperature.

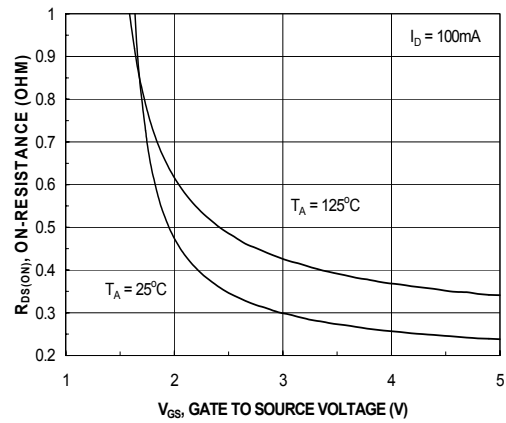


Figure 4. On-Resistance vs. Gate-to-Source Voltage.

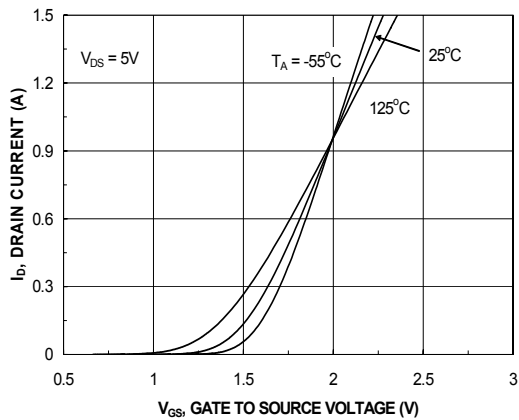


Figure 5. Transfer Characteristics.

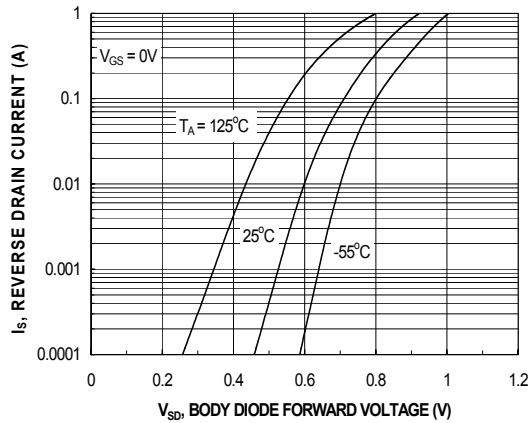
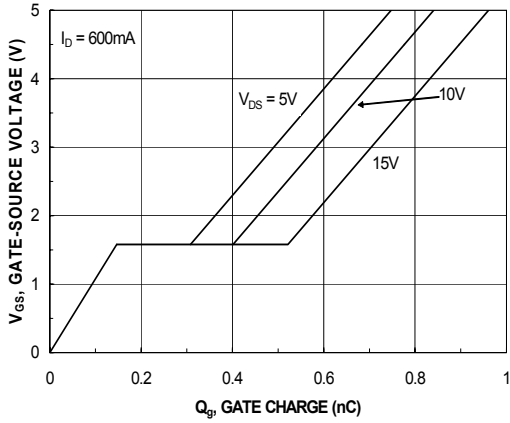
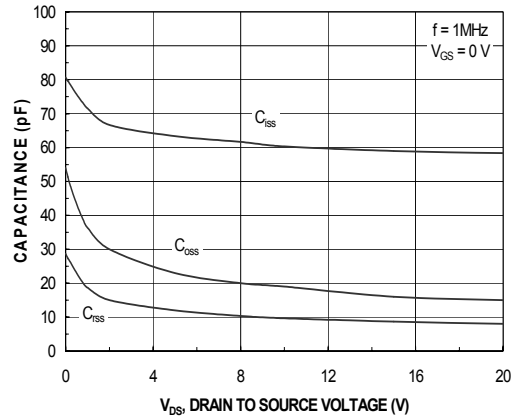


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current and Temperature.

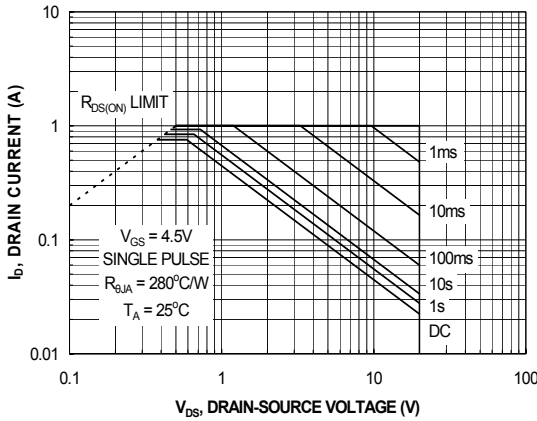
**Typical Characteristics Q1 (N-Channel)**



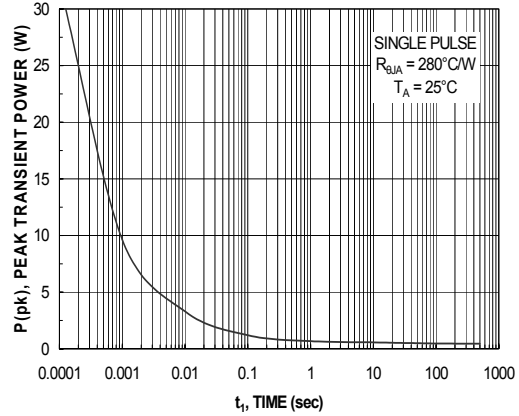
**Figure 7. Gate Charge Characteristics.**



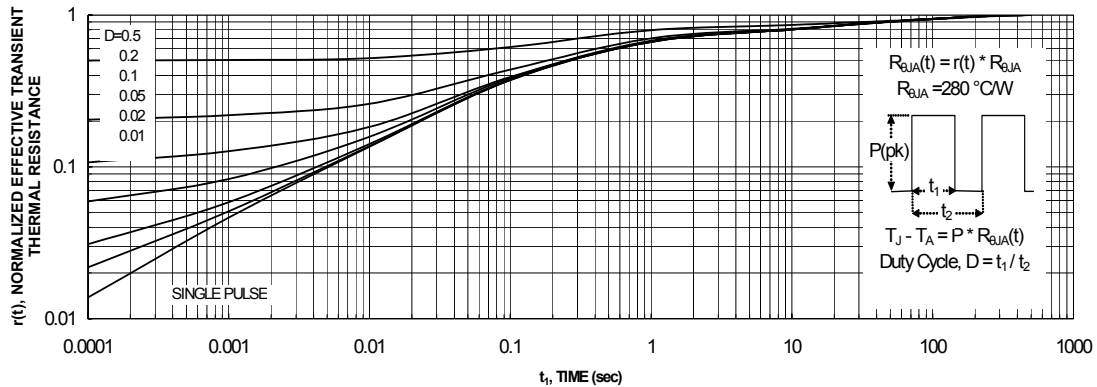
**Figure 8. Capacitance vs. Drain to source voltage.**



**Figure 9. Maximum Safe Operating Area.**

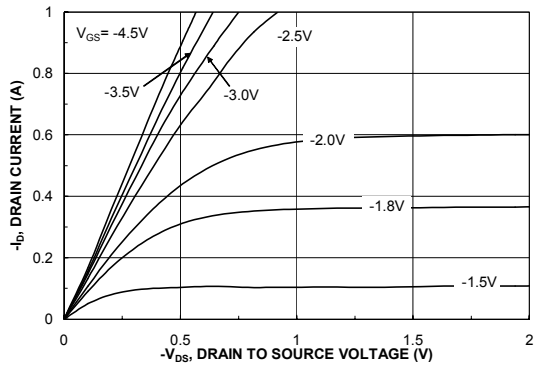


**Figure 10. Single Pulse Maximum Power Dissipation.**

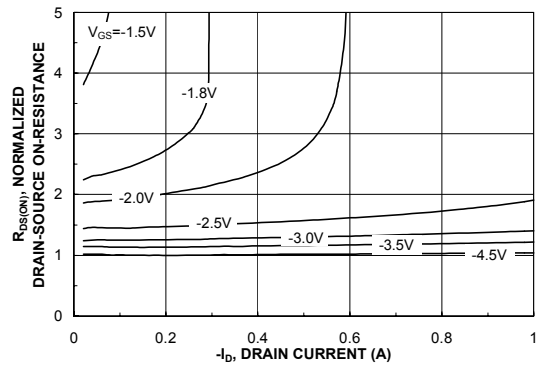


**Figure 11. Transient Thermal Response Curve.**  
Thermal characterization performed using the conditions described in Note 1b.  
Transient thermal response will change depending on the circuit board design.

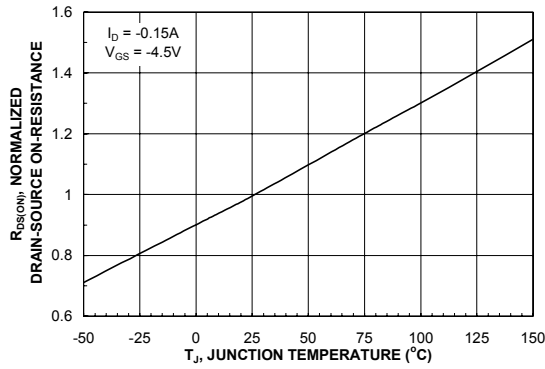
**Typical Characteristics Q2 (P-Channel)**



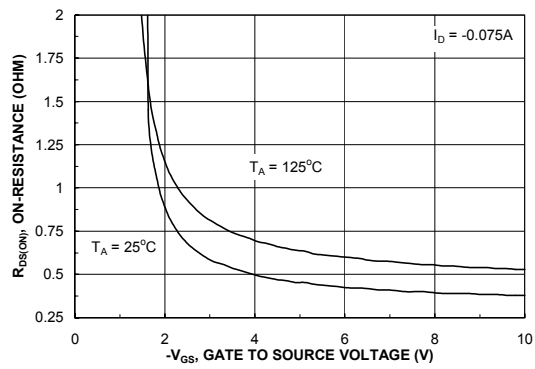
**Figure 1. On-Region Characteristics.**



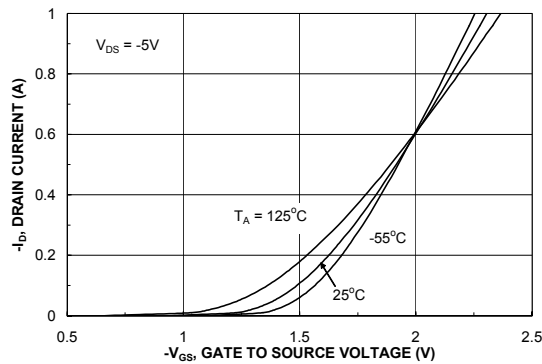
**Figure 2. Normalized on-Resistance vs. Drain Current and Gate Voltage.**



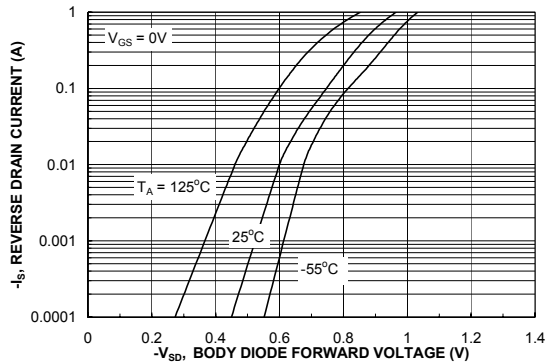
**Figure 3. Normalized on-Resistance vs. Temperature.**



**Figure 4. On-Resistance vs. Gate-to-Source Voltage.**



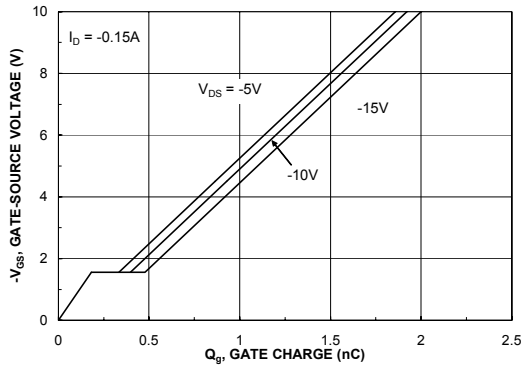
**Figure 5. Transfer Characteristics.**



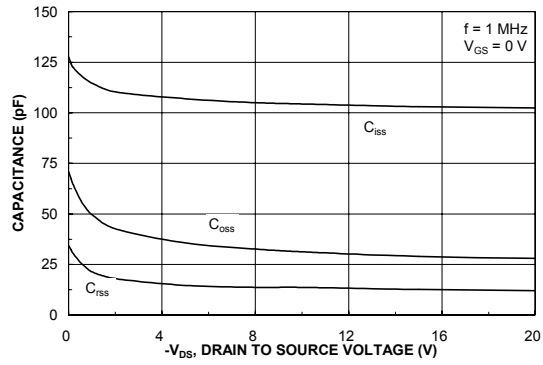
**Figure 6. Source to Drain Diode Forward Voltage vs. Source Current and Temperature.**



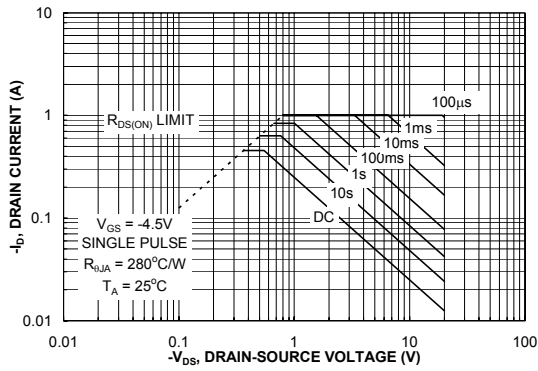
**Typical Characteristics Q2 (P-Channel)**



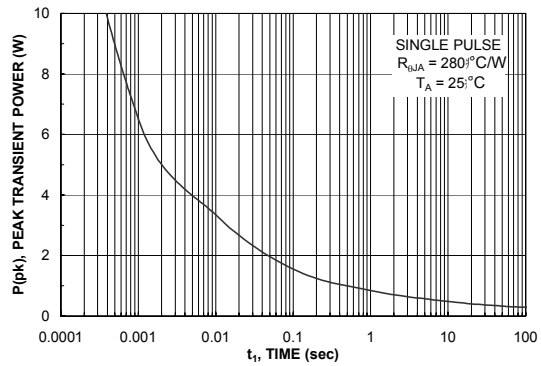
**Figure 7. Gate Charge Characteristics.**



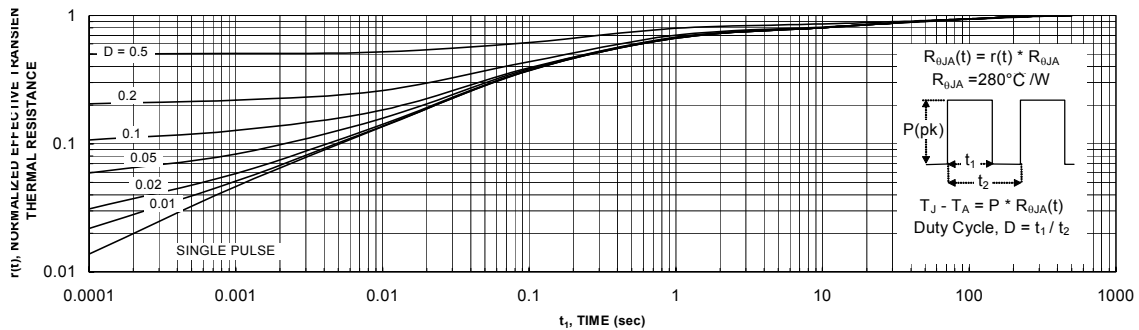
**Figure 8. Capacitance vs. Drain to source voltage.**



**Figure 9. Maximum Safe Operating Area.**



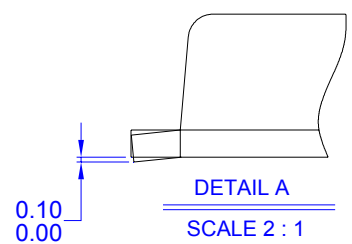
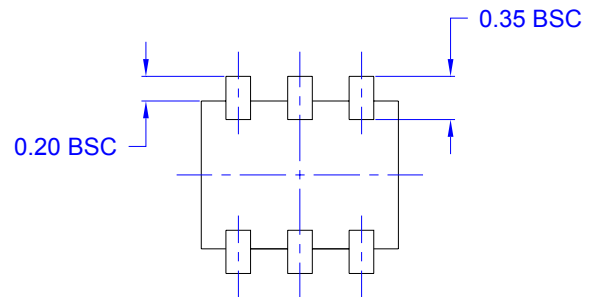
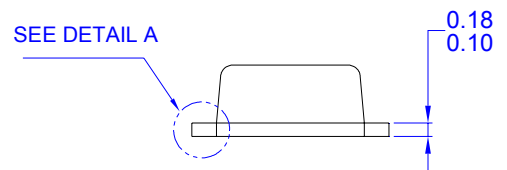
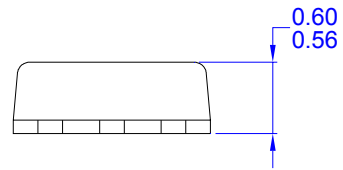
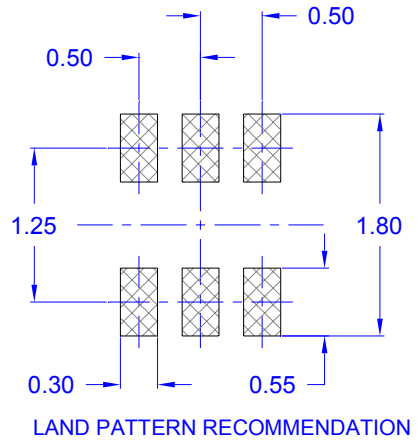
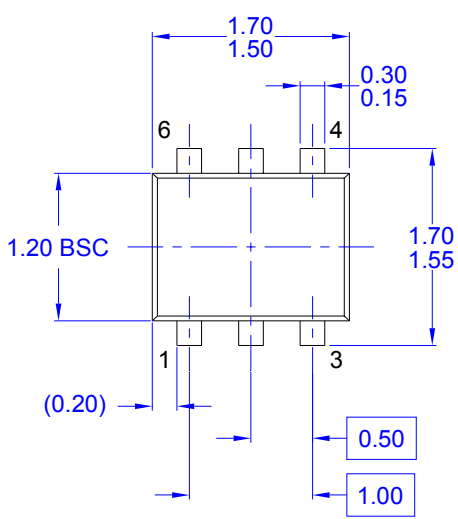
**Figure 10. Single Pulse Maximum Power Dissipation.**



**Figure 11. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

**Dimensional Outline and Pad Layout**



- NOTES: UNLESS OTHERWISE SPECIFIED  
 A) THIS PACKAGE CONFORMS TO EIAJ SC89 PACKAGING STANDARD.  
 B) ALL DIMENSIONS ARE IN MILLIMETERS.  
 C) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

## TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACE <sup>x</sup> <sup>TM</sup>	FACT Quiet Series <sup>TM</sup>	OCX <sup>TM</sup>	SILENT SWITCHER <sup>®</sup>	UniFET <sup>TM</sup>
ActiveArray <sup>TM</sup>	GlobalOptoisolator <sup>TM</sup>	OCXPro <sup>TM</sup>	SMART START <sup>TM</sup>	UltraFET <sup>®</sup>
Bottomless <sup>TM</sup>	GTO <sup>TM</sup>	OPTOLOGIC <sup>®</sup>	SPM <sup>TM</sup>	VCX <sup>TM</sup>
Build it Now <sup>TM</sup>	HiSeC <sup>TM</sup>	OPTOPLANAR <sup>TM</sup>	Stealth <sup>TM</sup>	Wire <sup>TM</sup>
CoolFET <sup>TM</sup>	I <sup>2</sup> C <sup>TM</sup>	PACMAN <sup>TM</sup>	SuperFET <sup>TM</sup>	
CROSSVOLT <sup>TM</sup>	<i>i-Lo</i> <sup>TM</sup>	POP <sup>TM</sup>	SuperSOT <sup>TM</sup> -3	
DOMET <sup>TM</sup>	ImpliedDisconnect <sup>TM</sup>	Power247 <sup>TM</sup>	SuperSOT <sup>TM</sup> -6	
EcoSPARK <sup>TM</sup>	IntelliMAX <sup>TM</sup>	PowerEdge <sup>TM</sup>	SuperSOT <sup>TM</sup> -8	
E <sup>2</sup> CMOS <sup>TM</sup>	ISOPLANAR <sup>TM</sup>	PowerSaver <sup>TM</sup>	SyncFET <sup>TM</sup>	
EnSigna <sup>TM</sup>	LittleFET <sup>TM</sup>	PowerTrench <sup>®</sup>	TCM <sup>TM</sup>	
FACT <sup>TM</sup>	MICROCOUPLER <sup>TM</sup>	QFET <sup>®</sup>	TinyBoost <sup>TM</sup>	
FAST <sup>®</sup>	MicroFET <sup>TM</sup>	QS <sup>TM</sup>	TinyBuck <sup>TM</sup>	
FAST <sup>r</sup> <sup>TM</sup>	MicroPak <sup>TM</sup>	QT Optoelectronics <sup>TM</sup>	TinyPWM <sup>TM</sup>	
FPS <sup>TM</sup>	MICROWIRE <sup>TM</sup>	Quiet Series <sup>TM</sup>	TinyPower <sup>TM</sup>	
FRFET <sup>TM</sup>	MSX <sup>TM</sup>	RapidConfigure <sup>TM</sup>	TinyLogic <sup>®</sup>	
	MSXPro <sup>TM</sup>	RapidConnect <sup>TM</sup>	TINYOPTO <sup>TM</sup>	
Across the board. Around the world. <sup>TM</sup>		μSerDes <sup>TM</sup>	TruTranslation <sup>TM</sup>	
The Power Franchise <sup>®</sup>		ScalarPump <sup>TM</sup>	UHC <sup>TM</sup>	
Programmable Active Droop <sup>TM</sup>				

## DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

## LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
- A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

## PRODUCT STATUS DEFINITIONS

### Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

## OUR CERTIFICATE

DiGi provide top-quality products and perfect service for customer worldwide through standardization, technological innovation and continuous improvement. DiGi through third-party certification, we stricly control the quality of products and services. Welcome your RFQ to

Email: [Info@DiGi-Electronics.com](mailto:Info@DiGi-Electronics.com)



Tel: +00 852-30501935

RFQ Email: [Info@DiGi-Electronics.com](mailto:Info@DiGi-Electronics.com)

DiGi is a global authorized distributor of electronic components.